
**Particle size analysis — Image analysis
methods —**

**Part 2:
Dynamic image analysis methods**

Analyse granulométrique — Méthodes par analyse d'images —

Partie 2: Méthodes par analyse d'images dynamiques

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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights. Details of any patent rights identified during the development of the document will be in the Introduction and/or on the ISO list of patent declarations received (see www.iso.org/patents).

Any trade name used in this document is information given for the convenience of users and does not constitute an endorsement.

For an explanation on the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the World Trade Organization (WTO) principles in the Technical Barriers to Trade (TBT) see the following URL: www.iso.org/iso/foreword.html.

This document was prepared by Technical Committee ISO/TC 24, *Particle characterization including sieving*, Subcommittee SC 4, *Particle characterization*.

This second edition cancels and replaces the first edition (ISO 13322-2:2006), which has been technically revised.

The main changes compared to the previous edition are as follows:

- the text has been aligned with changes introduced in ISO 13322-1:2014;
- clauses on instrumentation (principle) and operational procedures have been significantly expanded;
- a new clause on accuracy and instrument qualification using particulate reference materials has been added.

A list of all parts in the ISO 13322 series can be found on the ISO website.

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at www.iso.org/members.html.

Introduction

The ISO 13322 series is applicable to the analysis of images for the purpose of determining particle size distributions. The purpose of this document is to provide guidance for measuring and describing particle size distribution, using image analysis methods where particles are in motion. This entails using techniques for dispersing particles in liquid or gas, taking in-focus, still images of them while the particles are moving and subsequently analysing the images. This methodology is called dynamic image analysis.

There are several image capture methods. Some typical methods are described in this document.

ISO 13322-1 on static image analysis methods assumes that an adequate image has already been captured and concentrates upon the analysis of these images.

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Particle size analysis — Image analysis methods —

Part 2: Dynamic image analysis methods

1 Scope

This document describes a method to transfer the images from particles having relative motion to binary images within practical systems, in which the particles in the images are individually separated. Images of moving particles are created by an optical image capture device. Effects of particle movement on the images are either minimized by the instrumentation or corrected by software procedures. This method is applicable to the particle images that are clearly distinguishable from static background. Further processing of the binary image, which is then considered as static, is described in ISO 13322-1. A dynamic image analysis system is capable of measuring a higher number of particles compared to static image analysis systems. This document provides guidance on instrument qualification for particle size distribution measurements by using particulate reference materials. This document addresses the relative movement of the particles with respect to each other, the effect of particle movement on the image (motion blur), the movement and position along the optical axis (depth of field), and the orientation of the particles with respect to the camera.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 9276-1, *Representation of results of particle size analysis — Part 1: Graphical representation*

ISO 9276-2, *Representation of results of particle size analysis — Part 2: Calculation of average particle sizes/diameters and moments from particle size distributions*

ISO 9276-6, *Representation of results of particle size analysis — Part 6: Descriptive and quantitative representation of particle shape and morphology*

ISO 13322-1, *Particle size analysis — Image analysis methods — Part 1: Static image analysis methods*

ISO 14488, *Particulate materials — Sampling and sample splitting for the determination of particulate properties*

ISO/IEC 17025, *General requirements for the competence of testing and calibration laboratories*

3 Terms, definitions and symbols

3.1 Terms and definitions

For the purposes of this document, the terms and definitions given in ISO 13322-1 and the following apply.

ISO and IEC maintain terminology databases for use in standardization at the following addresses:

— ISO Online browsing platform: available at <https://www.iso.org/obp>

— IEC Electropedia: available at <https://www.electropedia.org/>